

FORM PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office		Attorney Docket No.: MLNR-06501		Serial No.: 09/715,556		
INFORMATION DISCLOSURE STATEMENT BY APPLICANT <small>(Use Several Sheets If Necessary)</small>				Applicant: Gwilym Luff				
				Filing Date: November 17, 2000		Group Art Unit: 2631		
(37 CFR § 1.98(b))								
U.S. PATENT DOCUMENTS								
Examiner Initials	Serial / Patent Number	Issue Date	Applicant / Patentee		Class	Subclass	Filing Date	
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JP	AC	5,245,565	Petersen et al.		364	825	07/31/91	
JP	AD	5,936,474	Rousselin		331	34	03/28/97	
	AE							
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FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS								
		Document Number	Publication Date	Country / Patent Office	Class	Subclass	Translation	
							Yes	No
JP	AQ	EP 0 344 852 A1	12/06/89	EP	H03H	11/04		X
JP	AR	EP 0 576 082 A1	12/29/93	EP	H04B	1/26		X
JP	AS	EP 0 660 504 A1	06/28/95	EP	H03B	5/12		X
JP	AT	EP 0 723 335 A1	07/24/96	EP	H03J	7/02		X
JP	AU	EP 0 948 129 A1	10/06/99	EP	H03D	7/18		X
OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)								
Examiner: <i>[Signature]</i>					Date Considered: <i>1/20/04</i>			
EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

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## U.S. PATENT DOCUMENTS

Examiner Initials		Serial / Patent Number	Issue Date	Applicant / Patentee	Class	Subclass	Filing Date
JP	AA	5,953,640	09/14/99	Meador et al.	455	73	04/30/97
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## FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS

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							Yes	No
	AQ							
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JP	AS	Hidehiko Kuroda et al., "Development of Low-Power Consumption RPIF Single-Chip Transceiver IC for PHS," Doc. No. XP-000832839, pp. 161-167, Compound Semiconductor Device Division, NEC IC Microcomputer Systems, Ltd.
JP	AT	Angel Boveda et al., "GaAs Monolithic Single-Chip Transceiver," Doc. No. XP-000538492, pp. 31-34, IEEE, May 15, 1995.
	AU	References 'AS' and 'AT' considered by examiner 6/10/04 - Jan Parilla
	AV	
	AW	
	AX	
	AY	
	AZ	

Examiner:

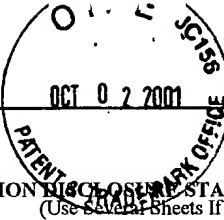
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Applicant: Gwilym Luff et al.

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Group Art Unit: 2631

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Examiner Initials	Serial / Patent Number	Issue Date	Applicant / Patentee	Class	Subclass	Filing Date
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Examiner:

*John A. G.*

Date Considered:

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JP	AR	EP 0 853 374 A1	07/15/98	EP	H03D	7/14		X
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	AT							
	AU							

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